TOSHIBA BIPOLAR DIGITAL INTEGRATED CIRCUIT SILICON MONOLITHIC

TD62308AP,TD62308F,TD62308AF

4CH LOW INPUT ACTIVE HIGH-CURRENT DARLINGTON SINK DRIVER

The TD62308AP F AF are non-inverting transistor array which are comprised of four NPN darlington output stages and PNP

These devices are low level input active driver and are suitable for operation with TTL, 5 V CMOS and 5 V Microprocessor which have sink current output drivers.

Applications include relay, hammer, lamp and stepping moter drivers.

FEATURES

- Output current (single output) 1.5 A (Max)
- High sustaining voltage output 35 V (Min) (TD62308F)

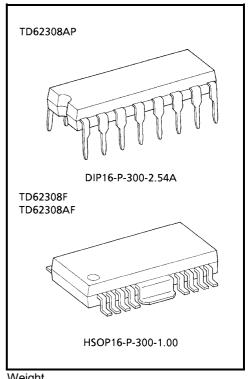
50 V (Min)

(TD62308AP, TD62308AF)

- Output clamp diodes
- Input compatible with TTL and 5 V CMOS
- Low level active inputs
- Standard supply voltage
- Two VCC terminals VCC1, VCC2 (separeted)
- GND and SUB terminal = heat sink

Package type-AP : DIP-16 pin

Package type-F, AF: HSOP-16 pin

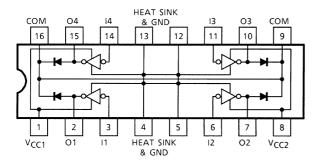


Weight

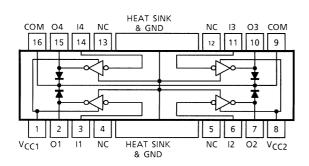
DIP16-P-300-2.54A : 1.11 g (Typ.) HSOP16-P-300-1.00 : 0.50 g (Typ.)

PIN CONNECTION (TOP VIEW)

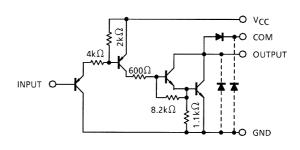
TD62308AP



TD62308F, TD62308AF



SCHEMATICS (EACH DRIVER)



Note: The input and output parasitic diodes cannot be used as clamp



MAXIMUM RATINGS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	RATING	UNIT		
Supply Voltage	V _{CC}	-0.5~10	V		
Output Sustaining Voltage	F	V==	-0.5~35	V	
	AP, AF	V _{CE} (SUS)	-0.5~50	V	
Output Current	lout	1.5	A / ch		
Input Current	I _{IN}	-10	mA		
Input Voltage	V _{IN}	V _{IN} -0.5~30			
Clamp diada Dayaraa Valtaga	F	\/-	35	V	
Clamp diode Reverse Voltage	AP, AF	V _R	50	V	
Clamp Diode Forward Current	l _F	1.5	Α		
Power Discipation	AP	D-	1.47 / 2.7 (Note 1)	· w	
Power Dissipation	F, AF	P _D	0.9 / 1.4 (Note 2)		
Operating Temperature		T _{opr}	-40~85	°C	
Storage Temperature		T _{stg}	-55~150	°C	

Note 1: On Glass Epoxy PCB ($50 \times 50 \times 1.6$ mm Cu 50%) Note 2: On Glass Epoxy PCB ($60 \times 30 \times 1.6$ mm Cu 50%)

RECOMMENDED OPERATING CONDITIONS (Ta = $-40 \sim 85$ °C)

CHARACTERISTIC		SYMBOL	CONDITION		MIN	TYP.	MAX	UNIT
Supply Voltage		V _{CC}	_		4.5	_	5.5	V
Outrot Outrining Valley	F	V _{CE} (SUS)		0	_	35	V	
Output Sustaining Voltage	AP, AF		_		0	_		50
			DC 1 circuit, Ta = 25°C		0	_	1250	
Output Current	AP	Іоит	T_{pw} = 25 ms 4 circuits Ta = 85°C T_j = 120°C	Duty = 10%	0	_	1250	mA / ch
	AP			Duty = 50%	0	_	700	
	E ^E			Duty = 10%	0	_	1250	
	F, AF			Duty = 50%	0	_	390	
Input Voltage		V _{IN}			0	_	25	V
Input Voltage	Output On	V _{IN (ON)}	-		0	_	V _{CC} -3.6	V
	Output Off	V _{IN (OFF)}	-		V _{CC} -1.0	_	V _{CC}	
Valtage	F	V-	_		_	_	35	- V
	AP, AF	V _R	_		_	_	50	
Clamp Diode Forward Current		I _F			_	_	1.25	Α
Power Dissipation	AP	P _D	Ta = 85°C	(Note 1)		_	1.4	W
	F, AF		Ta = 85°C	(Note 2)	_		0.7	7 "

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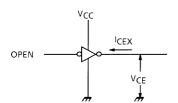
Note 1: On Glass Epoxy PCB ($50 \times 50 \times 1.6$ mm Cu 50%) Note 2: On Glass Epoxy PCB ($60 \times 30 \times 1.6$ mm Cu 50%)

ELECTRICAL CHARACTERISTICS (Ta = 25°C)

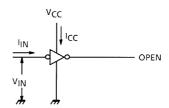
CHARACTERISTIC		SYMBOL	TEST CIR- CUIT	TEST CONDITION		MIN	TYP.	MAX	UNIT
Output Leakage Current	AP, AF	I _{CEX}	1	V _{CE} = 50 V, Ta = 25°C		_	_	50	μА
				V _{CE} = 50 V, Ta = 85°C		_	_	100	
	F			V _{CE} = 35 V, Ta = 25°C		_	_	50	
	<u>'</u>			V _{CE} = 35 V, Ta = 85°C		_	_	100	
Output Saturation Voltage		V _{CE (sat)}	3	I _{OUT} = 1.25 A		_	_	1.8	V
Cutput Cuturation Voltage	Output Saturation Voltage			I _{OUT} = 0.7 A	= 0.7 A		_	1.3	
Input Voltage	"H" Level	V_{IH}	_	_		V _{CC} -1.6	_	25	V
	"L" Level	V _{IL}	_	_		_	_	V _{CC} -3.6	
Innert Comment	"H" Level	I _{IH}		_		_	_	10	μA
Input Current	"L" Level	I _{IL}	-			_	-0.05	-0.36	mA
Clamp Diode Reverse	AP, AF	I-	4	V _R = 50 V, Ta = 25°C		_	_	50	μA
Current	F	I _R		V _R = 35 V, Ta = 25°C		_	_	50	μΑ
Clamp Diode Forward Voltage		V _F	5	I _F = 1.25 A		_	1.5	2.0	V
Supply Current	Output On	I _{CC (ON)}	2	V _{CC} = 5.5 V, V _{IN} = 0 V		_	8.5	12.5	mA / ch
	Output Off	ICC (OFF)		V _{CC} = 5.5 V, V _{IN} = V _{CC}		_	_	1.0	μA
Turn-On Delay	F	t _{ON}	- 6	0 45 5	V _{OUT} = 35 V R _L = 28 Ω		0.0		μs
	AP, AF				V _{OUT} = 50 V R _L = 40 Ω	_	0.2	_	
Turn-Off Delay	F			C _L = 15 pF	V _{OUT} = 35 V R _L = 28 Ω		E 0	_	
	AP, AF	t _{ON}			V _{OUT} = 35 V R _L = 40 Ω		5.0		

TEST CIRCUIT

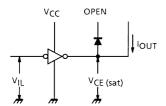
1. ICEX



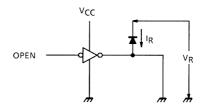
2. Icc



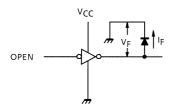
3. V_{CE (sat)}



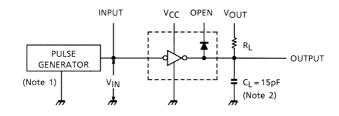
4. I_R

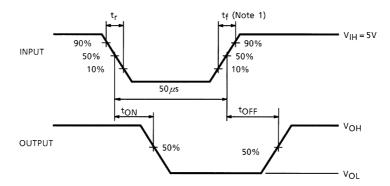


5. V_F



6. ton, toff





Note 1: Pulse width 50 µs, duty cycle 10%

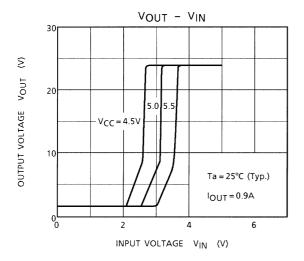
Output impedance 50 Ω tr \leq 5 ns, tf \leq 10 ns

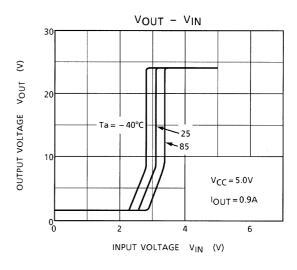
Note 2: CL includes probe and jig capacitance.

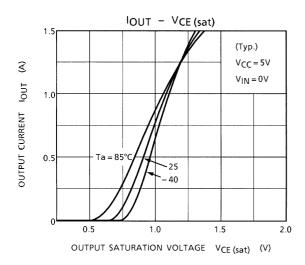
PRECAUTIONS for USING

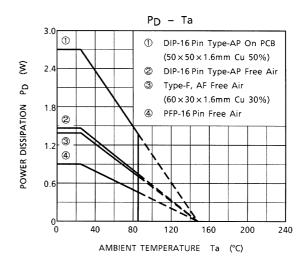
(1) This IC does not include built-in protection circuits for excess current or overvoltage. If this IC is subjected to excess current or overvoltage, it may be destroyed. Hence, the utmost care must be taken when systems which incorporate this IC are designed. Utmost care is necessary in the design of the output line, VCC, COMMON and GND line since IC may be destroyed due to short-circuit between outputs, air contamination fault, or fault by improper grounding.

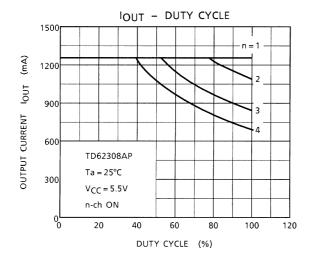
(2) When using this IC to drive an inductive load (such as a motor, solenoid, or relay), Toshiba recommend you use diodes (pins 9 and 16) to absorb the counter electromotive force generated when driving an inductive load.

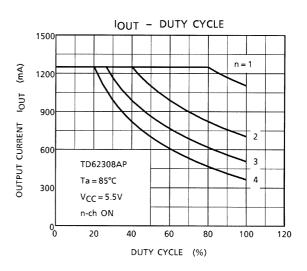


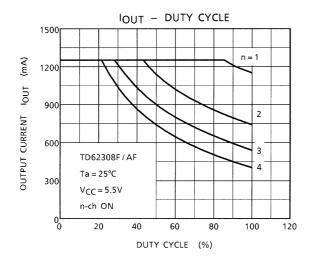


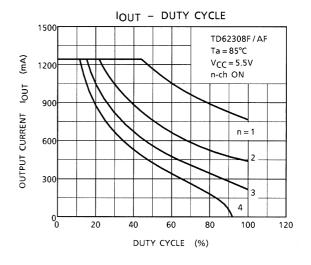






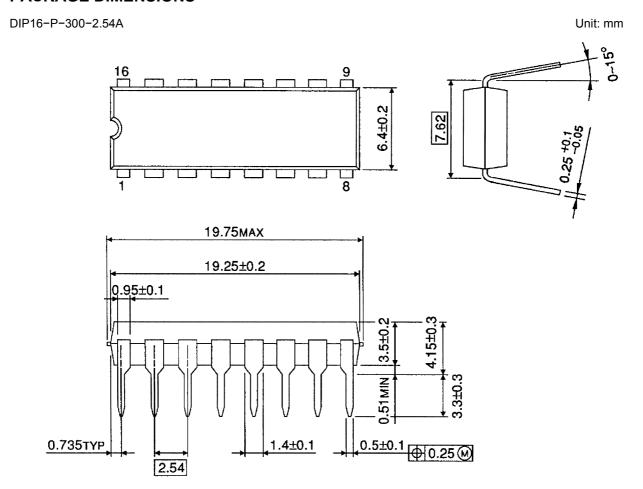






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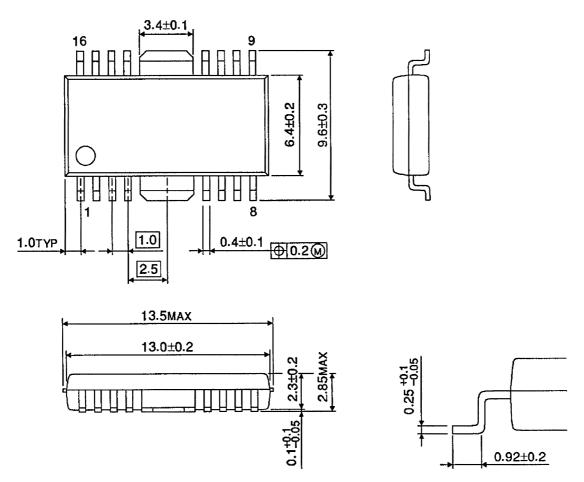
PACKAGE DIMENSIONS



Weight: 1.11 g (Typ.)

PACKAGE DIMENSIONS

HSOP16-P-300-1.00 Unit: mm



Weight: 0.50 g (Typ.)

RESTRICTIONS ON PRODUCT USE

000707EBA

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